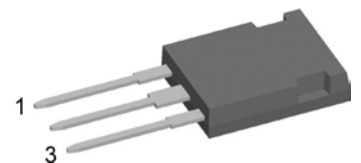
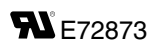
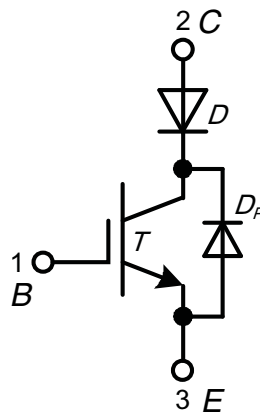


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Reverse blocking IGBT

$$\begin{aligned}
 V_{CES} &= 1200 \text{ V} \\
 I_{C25} &= 53 \text{ A} \\
 V_{CE(sat) \text{ typ.}} &= 3.0 \text{ V}
 \end{aligned}$$

Part number
IRA37IH1200HJ

Features / Advantages:

- Rugged XPT design (Xtreme light Punch Through) results in:
 - short circuit rated for 10 μ sec.
 - very low gate charge
 - low EMI
 - square RBSOA @ 3x Ic
- Thin wafer technology combined with the XPT design results in a competitive low $V_{CE(sat)}$
- Low V_F diode D
- Protection diode D_p

Applications:

- AC switch
- Heating systems
- Lamp control (dimming)
- Solid state relay

Package: ISOPLUS247

- Isolation Voltage: 3600V~
- Industry standard outline
- RoHS compliant
- Epoxy meets UL 94V-0
- Soldering pins for PCB mounting
- Backside: DCB ceramic
- Reduced weight
- Advanced power cycling

IGBT T				Ratings			
Symbol	Definitions	Conditions	min.	typ.	max.	Unit	
V_{CES}	collector emitter voltage				1200	V	
V_{GES}	max. DC gate voltage				± 20	V	
V_{GEM}	max. transient gate emitter voltage				± 30	V	
I_{C25}	collector current (die level)				58	A	
I_{C90}					37	A	
P_{tot}	total power dissipation (chip)				195	W	
$V_{CE(sat)}$	collector emitter saturation voltage, (chip)	$I_C = 35 \text{ A}; V_{GE} = 15 \text{ V}$			1.8	2.1	V
	component level between pin 2 and 3 *	$I_C = 35 \text{ A}; V_{GE} = 15 \text{ V}$			3.0	3.1	V
$V_{GE(th)}$	gate emitter threshold voltage	$I_C = 1.5 \text{ mA}; V_{GE} = V_{CE}$			5.4	5.9	6.5
I_{CES}	collector emitter leakage current	$V_{CE} = V_{CES}; V_{GE} = 0 \text{ V}$			0.1	0.1	mA
					0.1		mA
I_{GES}	gate emitter leakage current	$V_{GE} = \pm 20 \text{ V}; V_{CE} = 0 \text{ V}$				500	μA
$Q_{G(on)}$	total gate charge	$V_{CE} = 600 \text{ V}; V_{GE} = 15 \text{ V}; I_C = 35 \text{ A}$			106		nC
External diode DSEP 30-12 - diagramm see Fig. 1							
$t_{d(on)}$	turn-on delay time	$V_{CE} = 600 \text{ V}; I_C = 35 \text{ A}$ $V_{GE} = \pm 15 \text{ V}; R_G = 27 \Omega$	$T_{VJ} = 125^\circ\text{C}$		tbd		ns
t_r	current rise time				tbd		ns
$t_{d(off)}$	turn-off delay time				tbd		ns
t_f	current fall time				tbd		ns
E_{on}	turn-on energy per pulse				tbd		mJ
E_{off}	turn-off energy per pulse				tbd		mJ
Internal diode - diagramm see Fig. 2							
$t_{d(on)}$	turn-on delay time	$V_{CE} = 600 \text{ V}; I_C = 35 \text{ A}$ $V_{GE} = \pm 15 \text{ V}; R_G = 27 \Omega$	$T_{VJ} = 125^\circ\text{C}$		tbd		ns
t_r	current rise time				tbd		ns
$t_{d(off)}$	turn-off delay time				tbd		ns
t_f	current fall time				tbd		ns
E_{on}	turn-on energy per pulse				tbd		mJ
E_{off}	turn-off energy per pulse				tbd		mJ
$E_{rec int}$	reverse recovery losses internal		tbd		mJ		
RBSOA	reverse bias safe operating area	$V_{GE} = \pm 15 \text{ V}; R_G = 27 \Omega$					
I_{CM}		$V_{CEmax} = 1200 \text{ V}$				105	A
SCSOA	short circuit safe operating area	$V_{CEmax} = 1200 \text{ V}$					
t_{SC}	short circuit duration	$V_{CE} = 900 \text{ V}; V_{GE} = \pm 15 \text{ V};$				10	μs
I_{SC}	short circuit current	$R_G = 27 \Omega; \text{non-repetitive}$				140	A
R_{thJC}	thermal resistance junction to case					0.64	K/W
R_{thCH}	thermal resistance case to heatsink					0.22	K/W

 * $V_{CE(sat)} \text{ component} = V_{CE(sat)} \text{ chip} + V_F \text{ chip} + 2 \cdot R_{pin-chip} \cdot I_C$

Fig. 1 turn-on/turn-off with external diode (DSEP 30-12)

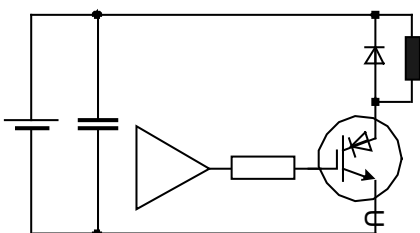
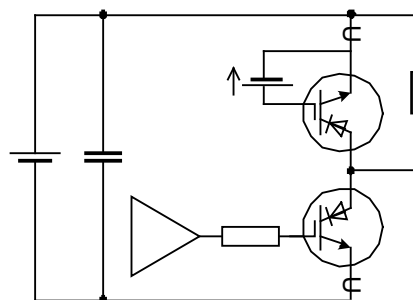


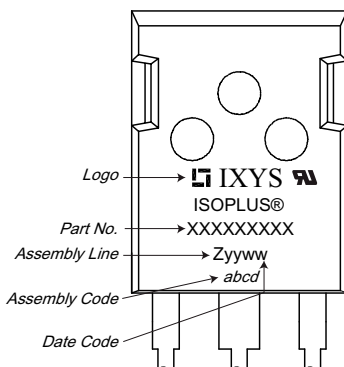
Fig. 2 turn-on/-off with internal diode



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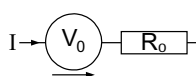
Diode D						
V_{RRM}	max. repetitive reverse voltage	$T_{VJ} = 25^{\circ}\text{C}$		1200	V	
I_{F25}	forward current (chip)	$T_C = 25^{\circ}\text{C}$		53	A	
I_{F80}		$T_C = 80^{\circ}\text{C}$		34	A	
V_F	forward voltage (chip)	$I_F = 35\text{ A}$	$T_{VJ} = 25^{\circ}\text{C}$ $T_{VJ} = 125^{\circ}\text{C}$	1.2 1.1	V V	
I_R	reverse current	$V_R = V_{RRM}$	$T_{VJ} = 25^{\circ}\text{C}$ $T_{VJ} = 125^{\circ}\text{C}$	50	10 100	μA μA
Q_{rr}	reverse recovery charge	$V_R = 600\text{ V}$ $-di_F/dt = 400\text{ A}/\mu\text{s}$ $I_F = 20\text{ A}; V_{GE} = 0\text{ V}$	$T_{VJ} = 125^{\circ}\text{C}$	tdb	μC	
I_{RM}	max. reverse recovery current			tdb	A	
t_{rr}	reverse recovery time			tdb	ns	
E_{rec}	reverse recovery energy			tdb	mJ	
R_{thJC}	thermal resistance junction to case			1.7	K/W	
R_{thCH}	thermal resistance case to heatsink			0.57	K/W	

Package ISOPLUS247			Ratings			
Symbol	Definitions	Conditions	min.	typ.	max.	Unit
I_{RMS}	RMS current	per terminal			70	A
T_{stg}	storage temperature		-55		150	$^{\circ}\text{C}$
T_{VJ}	virtual junction temperature		-40		150	$^{\circ}\text{C}$
Weight				6		g
F_C	mounting force with clip		20		120	N
$d_{Spp/App}$	creepage distance on surface / striking distance through air	terminal to terminal	2.7			mm
$d_{Spb/Apb}$		terminal to backside	4.1			mm
V_{ISOL}	isolation voltage	$t = 1\text{ second}$	3600			V
		$t = 1\text{ minute}$	3000			V
$R_{pin-chip}$	resistance pin to chip at 125°C	$V_{CE(sat)\text{ comp.}} = V_{CE(sat)\text{ chip}} + V_F\text{ chip} + 2 \cdot R_{pin-chip} \cdot I_C$			1.2	m Ω

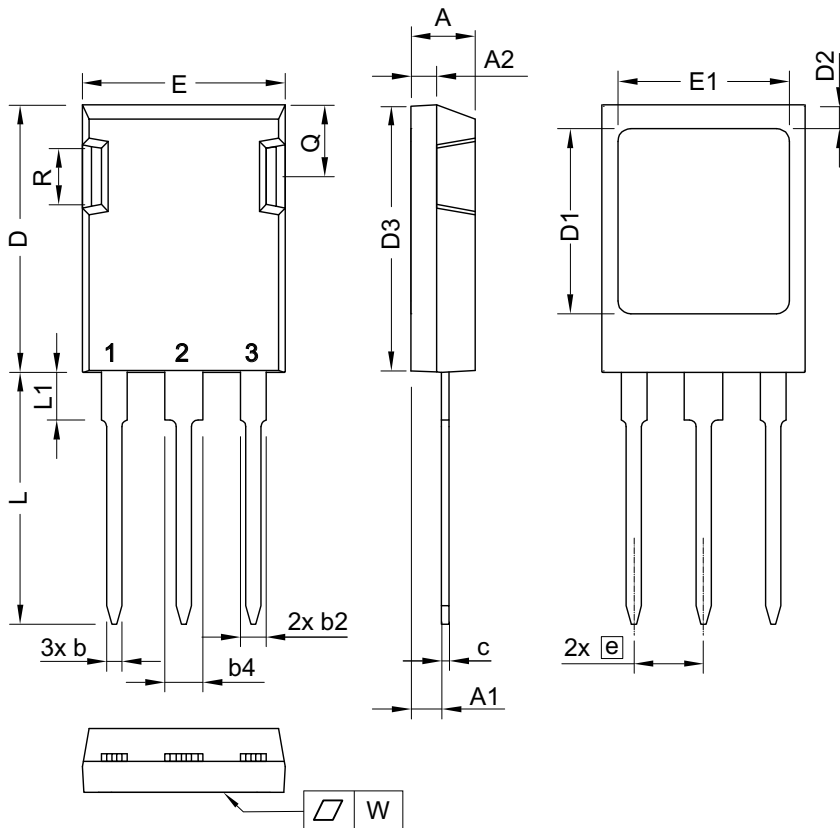
Product Marking

Part number

- I = IGBT
- R = Reverse blocking IGBT
- A = Generation 1
- 37 = Current Rating [A]
- IH = Copack with series connected diode
- 1200 = Reverse Voltage [V]
- HJ = ISOPLUS247 (3)

Ordering	Part Name	Marking on Product	Delivering Mode	Base Qty	Ordering Code
Standard	IRA37IH1200HJ	IRA37IH1200HJ	Tube	30	515175

Equivalent Circuits for Simulation *on die level


	IGBT	Diode	
$T_{VJ} = 150^{\circ}\text{C}$	$T_{VJ} = 150^{\circ}\text{C}$		
$V_{0\text{ max}}$	1.1	0.86	V
$R_{0\text{ max}}$	39	6.7	m Ω

Outlines SimBus F


Dim.	Millimeter		Inches	
	min	max	min	max
A	4.83	5.21	0.190	0.205
A1	2.29	2.54	0.090	0.100
A2	1.91	2.16	0.075	0.085
b	1.14	1.40	0.045	0.055
b2	1.91	2.20	0.075	0.087
b4	2.92	3.24	0.115	0.128
c	0.61	0.83	0.024	0.033
D	20.80	21.34	0.819	0.840
D1	15.75	16.26	0.620	0.640
D2	1.65	2.15	0.065	0.085
D3	20.30	20.70	0.799	0.815
E	15.75	16.13	0.620	0.635
E1	13.21	13.72	0.520	0.540
e	5.45 BSC		0.215 BSC	
L	19.81	20.60	0.780	0.811
L1	3.81	4.38	0.150	0.172
Q	5.59	6.20	0.220	0.244
R	4.25	5.50	0.167	0.217
W	-	0.10	-	0.004

Die konvexe Form des Substrates ist typ. < 0.04 mm über der Kunststoffoberfläche der Bauteilunterseite
 The convex bow of substrate is typ. < 0.04 mm over plastic surface level of device bottom side

Die Gehäuseabmessungen entsprechen dem Typ TO-247 AD gemäß JEDEC außer Schraubloch und L_{max} .
 This drawing will meet all dimensions requirement of JEDEC outline TO-247 AD except screw hole and except L_{max} .

